

**AMENDMENTS TO THE CLAIMS**

This listing of claims will replace all prior versions, and listings, of claims in the application:

**LISTING OF CLAIMS**

-1- (Currently Amended)

A process for depositing a nanocrystalline diamond film with a grain size between 1 and 100 nm on a surface of a substrate, which comprises:

- (a) providing a plasma generating apparatus
- 5 for depositing the diamond film on the substrate from the plasma, including a plasma source employing a radiofrequency, including UHF or microwave, wave coupler means which is metallic and in the shape of a hollow cavity and which is excited in a TM mode of
- 10 resonance, and wherein an insulated ~~the~~ chamber means has a central longitudinal axis in common with the coupler means and is mounted in closely spaced and sealed relationship to an area of the coupler means with an opening from the chamber means at one end; gas
- 15 supply means for providing a gas which is ionized to form the plasma in the chamber means, wherein the

radiofrequency wave applied to the coupler means  
creates and maintains the plasma around the central  
longitudinal axis (A-A) in the chamber means; movable  
20 metal plate means in the cavity mounted in the coupler  
means perpendicular to the central longitudinal axis  
and movable along the central longitudinal axis towards  
and away from the chamber means; and a movable probe  
means connected to and extending inside the coupler  
25 means for coupling the radiofrequency waves to the  
coupler means;

(b) providing the substrate, wherein the  
surface to be placed in the plasma has been roughened  
and cleaned; and

30 (c) providing the substrate in the insulated  
chamber means on a substrate holder adjacent to the  
plasma generated in the chamber means, wherein the gas  
in the chamber means is at a pressure between 50 and  
300 Torr in the presence of the radiofrequency waves  
35 for generating the plasma, wherein the gas is ninety  
percent by volume or more of argon along with methane  
and optionally hydrogen and essentially free from

oxygen or nitrogen and wherein the chamber means is  
essentially free from leaks of nitrogen or oxygen or  
40 mixtures thereof into the chamber means, so as to  
generate the plasma and to deposit the nanocrystalline  
diamond film on the substrate.

-2-(Original)

The process of Claim 1 wherein the substrate  
has a dimension with a surface area greater than about  
20 cm<sup>2</sup>.

-3-(Original)

The process of Claim 1 or 2 wherein the  
microwave is at 2.45 GHz.

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-4- (Original)

The process of Claim 1 or 2 wherein the  
microwave is at 915 MHz.

-5- (Original)

The process of Claim 1 or 2 wherein the film has a thickness of at least about 50 nm micrometers.

-6- (Withdrawn)

A nanocrystalline film prepared by the process of Claim 1.

-7- (Withdrawn)

A nanocrystalline film prepared by the process of Claim 2.

-8- (Original)

The process of Claim 1 wherein the substrate is allowed to thermally float at a temperature between about 575°C and 900°C on a side exposed to the plasma.

-9- (Original)

The process of Claim 1 wherein diamond particles are used for providing the roughened surface by abrasion and wherein the diamond particles have a

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grain size between about 0.1 to several micrometers,  
which surface is then cleaned.

-10- (Original)

The process of Claim 1 wherein the pressure  
on the gas is between about 60 and 240 Torr and at a  
flow rate of between about 50 and 200 sccm.

-11- (Original)

The process of Claims 1 or 2 wherein the probe means is elongate and is mounted in the coupler means along the central longitudinal axis of the chamber means and coupler means with an end of the probe means in spaced relationship to the chamber means; and wherein stage means in the opening of the chamber which forms part of the cavity and provides for mounting the substrate, the stage means having a support surface which is in a plane around the longitudinal axis and which is pre-adjusted towards and away from the plasma in the chamber means so that the substrate can be coated with the diamond film from the plasma.

-12- (Original)

The process of Claims 1 or 2 wherein the insulated chamber is evacuated so that there is less than about 10 ppm of combined oxygen and nitrogen or nitrogen or oxygen alone as the gas which generates the plasma is provided in the chamber.

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-13- (Original)

The process of Claims 1 or 2 wherein the substrate is silicon and wherein the substrate holder is molybdenum.

-14- (Original)

The process of any one of Claims 1 or 2 wherein the substrate on which the diamond is deposited has a surface area with a diameter which is greater than about 8 cm.

-15- (Original)

The process of Claim 1 wherein the gas contains about 1% methane.

-16- (Original)

The process of Claim 1 wherein the mode of the plasma is selected from the group consisting of TM012 and TM013.



-17- (Original)

The process of Claim 1 wherein at pressures of greater than about 250 Torr the stage means can be optionally cooled.

-18- (Original)

The process of Claim 1 wherein the substrate is a silicon carbide seal and the holder is molybdenum which shields a first portion of the seal while allowing a portion of the seal to be coated with the  
5 nanocrystalline diamond.

-19- (Previously Presented)

The process of Claim 1 wherein the apparatus has a static magnetic field around the plasma which aids in coupling radiofrequency energy at electron cyclotron resonance and aids in confining ions in the  
5 plasma in an electrically insulated chamber means in the coupler means.